

**Search Notes**

Application/Control No.

10/625,664

Examiner

Thien M. Le

Applicant(s)/Patent under  
Reexamination

HABA, YOSHITO

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	462.01-462.45	5/9/2005	LTM
	472.01		
	472.02		
	472.03		
	454		
	455		
	470		
	469		
	494		
updated		5/9/2005	LTM

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
235	462 All		
	472 All		
	454	5/9/2005	LTM